

Dual N-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}$ (Ω)	I _D (A) ^a	Q _g (Typ.)			
60	0.095 at V _{GS} = 10 V	4.0	2.1 nC			
	0.100 at V _{GS} = 4.5 V	3.8	2.1110			

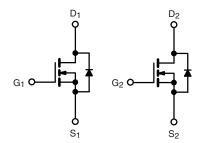
SO-8 Dual D_1 Top View

FEATURES

- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET® Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested

APPLICATIONS

- Battery Switch
- DC/DC Converter



N-Channel MOSFET N-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	60	V		
Gate-Source Voltage	V_{GS}	± 20	v		
	T _C = 25 °C		4.0		
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C	1_	3.4		
Continuous Diam Current (1) = 130 °C)	T _A = 25 °C	ID	3.1 ^{b, c}		
	T _A = 70 °C		2.5 ^{b, c}		
Pulsed Drain Current	I _{DM}	12	A		
0 1 0 0 0 1	T _C = 25 °C	1-	1.39		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	0.91 ^{b, c}		
Avalanche Current	L = 0.1 mH	I _{AS}	6		
Single-Pulse Avalanche Energy	L = 0.1 IIII	E _{AS}	1.8	mJ	
	T _C = 25 °C		1.66		
Mayimum Dawar Dissination	T _C = 70 °C	D	1.06	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	1.09 ^{b, c}	VV	
	T _A = 70 °C		0.7 ^{b, c}		
Operating Junction and Storage Temperature Range	T _J , T _{sta}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, d}	≤ 5 s	R _{thJA}	90	115	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	60	75	C/VV		

- a. Based on T_C = 25 °C.
 b. Surface Mounted on 1" x 1" FR4 board.
- d. Maximum under Steady State conditions is 120 °C/W.

服务热线:400-655-8788

RoHS HALOGEN FREE



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static					L	
Drain-Source Breakdown Voltage	V _{DS}	$V_{DS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	60			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			55		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	I _D = 250 μA		- 5		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1		3	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zara Cata Valtaga Drain Current	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V	_{3S} = 0 V		1	
Zero Gate Voltage Drain Current		V _{DS} = 60 V, V _{GS} = 0 V, T _J = 55 °C			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	8			Α
	В	V _{GS} = 10 V, I _D = 1.9 A		0.095		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 1.7 A		0.100		Ω
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15V, I _D = 1.9 A		5		S
Dynamic ^b					L	
Input Capacitance	C _{iss}			180		
Output Capacitance	C _{oss}			22		1
Reverse Transfer Capacitance	C _{rss}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		13		pF
Total Oata Ohanna	Qg	V _{DS} = 30 V, V _{GS} = 10 V, I _D = 1.9 A		4.2	6.1	nC
Total Gate Charge				2.1	3.2	
Gate-Source Charge	Q_{gs}	$V_{DS} = 30 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 1.9 \text{ A}$		0.7		
Gate-Drain Charge	Q_{gd}			1		
Gate Resistance	R _g	f = 1 MHz	0.6	2.2	5.1	Ω
Turn-On Delay Time	t _{d(on)}			4	6	- ns
Rise Time	t _r	V_{DD} = 30 V, R_L = 20 Ω		10	15	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 1.5 A, V_{GEN} = 10 V, R_G = 1 Ω		10	15	
Fall Time	t _f			7	10.5	
Turn-On Delay Time	t _{d(on)}			15	23	ns
Rise Time	t _r	V_{DD} = 30 V, R_L = 20 Ω		16	24	
Turn-Off Delay Time	t _{d(off)}	I_D = 1.5 A, V_{GEN} = 4.5 V, R_G = 1 Ω		11	17	
Fall Time	t _f			11	17	
Drain-Source Body Diode Characteristi	cs					
Continuous Source-Drain Diode Current	I _S	$T_C = 25 ^{\circ}C$			2.19	۸
Pulse Diode Forward Current ^a	I _{SM}				7	A
Body Diode Voltage	V _{SD}	I _S = 1.5 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			15	23	ns
Body Diode Reverse Recovery Charge	Q _{rr}	1 4 5 A dl/dt 400 A/vo T 25 20		10	15	nC
Reverse Recovery Fall Time	t _a	$I_F = 1.5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		12		
Reverse Recovery Rise Time	t _b	\dashv		3		ns

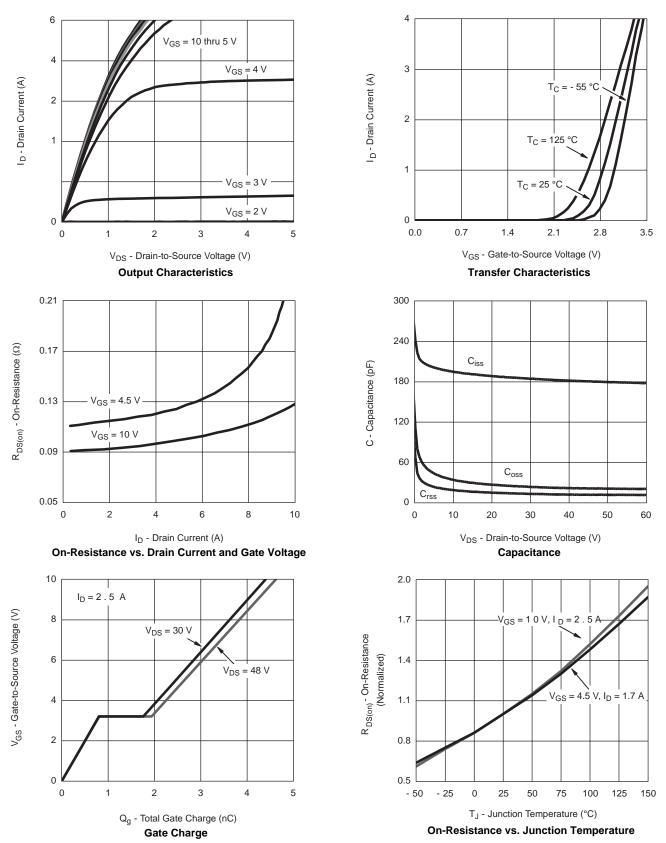
Notes:

- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

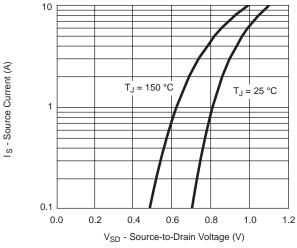


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

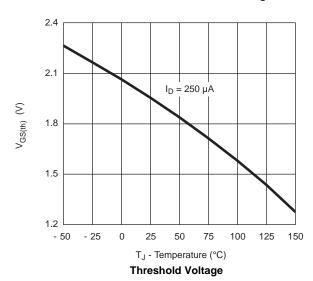




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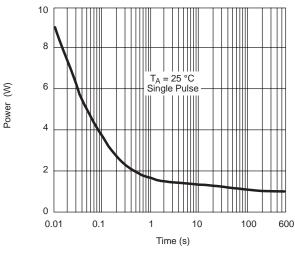


Source-Drain Diode Forward Voltage

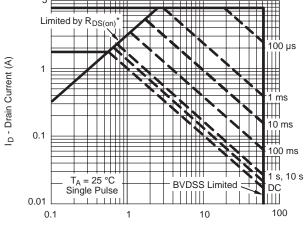


0.35
0.25
0.25
0.20
0.15
0.10 $T_{J} = 125 \, ^{\circ}\text{C}$ $T_{J} = 25 \, ^{\circ}\text{C}$ $T_{J} = 25 \, ^{\circ}\text{C}$ $T_{J} = 25 \, ^{\circ}\text{C}$

On-Resistance vs. Gate-to-Source Voltage







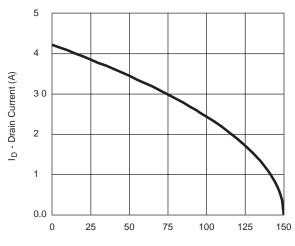
V_{DS} - Drain-to-Source Voltage (V)

Safe Operating Area

^{*} V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

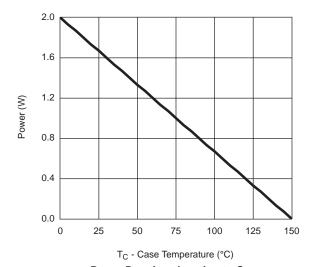


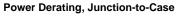
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

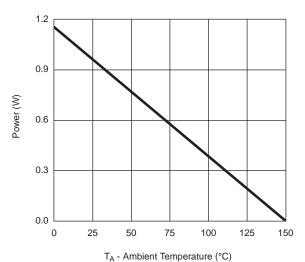


T_C - Case Temperature (°C)

Current Derating*





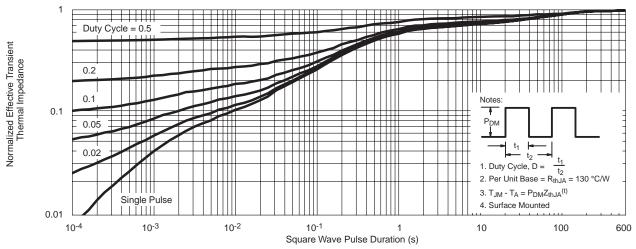


Power Derating, Junction-to-Ambient

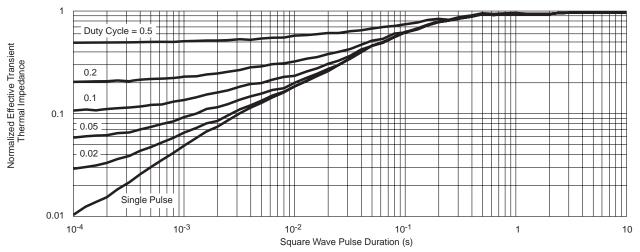
^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)



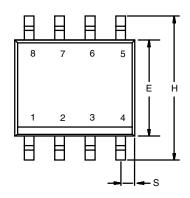
Normalized Thermal Transient Impedance, Junction-to-Ambient

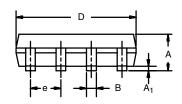


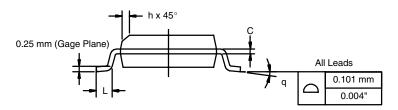
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







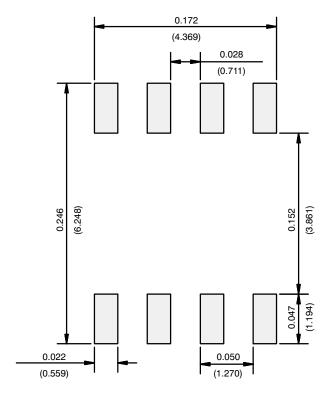
	MILLIM	IETERS	INC	HES	
DIM	Min	Max	Min	Max	
А	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
Е	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
FCN: C-06527-Rev. I. 11-Sep-06					

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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